Description

N-channel Enhancement Mode Power MOSFET

Features

- 60V, 3A
 - $R_{DS(ON)}$ Typ= 75m Ω @ V_{GS} = 10V $R_{DS(ON)}$ Typ= 85m Ω @ V_{GS} = 4.5V
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free

Applications

- Load Switch
- PWM Application
- Power Management

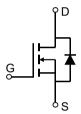








Marking and Pin Assignment



Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Outline	Package	Reel Size	Reel(pcs)	Per Carton (pcs)
S10	CRMLTL06100A	TAPING	SOT-23	7"	3000	120000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units	
V _{DS}	Drain-to-Source Voltage Gate-to-Source Voltage		60	V	
V_{GS}			±20	V	
	I _D Continuous Drain Current	T _A = 25°C	3	A	
I _D		T _A = 100°C	2		
I _{DM}	Pulsed Drain Current (1)		12	Α	
P_{D}	Power Dissipation T _A = 25°C		1.56	W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽²⁾		80	°C/W	
T_J , T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C	

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Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60V, V _{GS} = 0V	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0	1.4	2.0	V
	(0)	$V_{GS} = 10V, I_D = 3A$ -		75	100	mΩ
$R_{DS(ON)}$		$V_{GS} = 4.5V, I_D = 2A$	-	85	110	mΩ
Dynam	ic Characteristics					
C _{iss}	Input Capacitance		- (350	-	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 25V$, f = 1MHz		29	-	pF
C_{rss}	Reverse Transfer Capacitance	1 - 11/11/2	X-\	23	-	pF
Q_g	Total Gate Charge	V 04-40V		9	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 30V, I_{D} = 3A$	<u></u>	1.5	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} = 30 V, I _D = 3A	-	2	-	nC
Switch	ing Characteristics					
t _{d(on)}	Turn-On DelayTime		-	5	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 30V$	-	7	-	ns
$t_{d(off)}$	Turn-Off DelayTime	$I_D = 2A$, $R_{GEN} = 3\Omega$	-	37	-	ns
t _f	Turn-Off Fall Time) *	-	22	-	ns
Drain-S	Source Diode Characteristics and N	lax Ratings				
I _S	Maximum Continuous Drain to Source Diode Forward Current			-	3	А
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	12	А
V _{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 3A$	-	-	1.2	V

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- 2. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB
- 3. Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%.

Typical Performance Characteristics

Figure 1: Output Characteristics

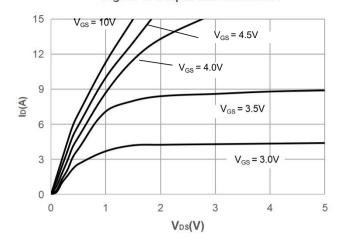


Figure 2: Typical Transfer Characteristics

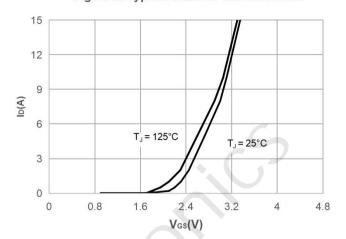


Figure 3: On-resistance vs. Drain Current

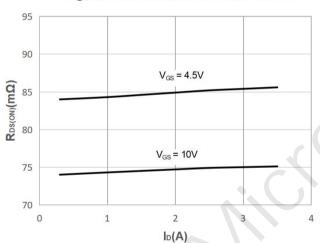


Figure 4: Body Diode Characteristics

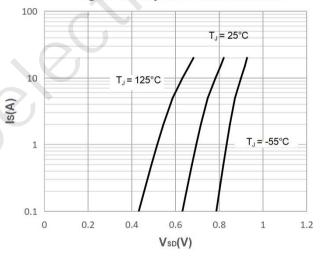


Figure 5: Gate Charge Characteristics

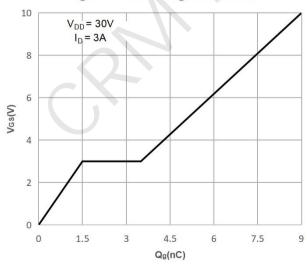
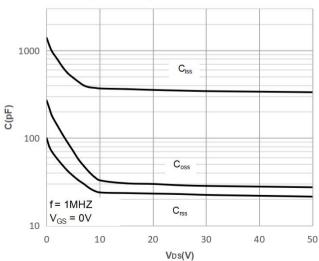


Figure 6: Capacitance Characteristics





Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs.
Junction Temperature

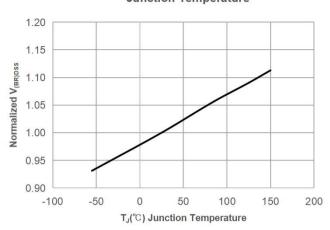


Figure 9: Maximum Safe Operating Area

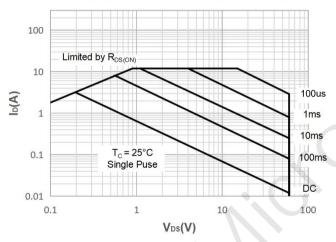


Figure 11: Normalized Maximum Transient
Thermal Impedance

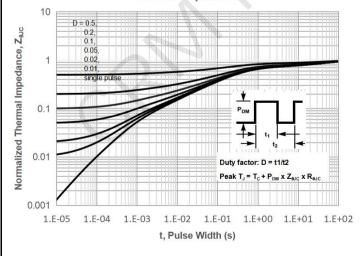


Figure 8: Normalized on Resistance vs.
Junction Temperature

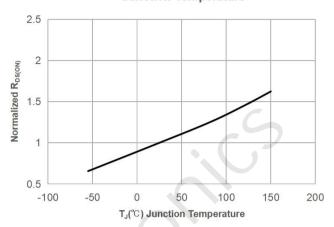


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

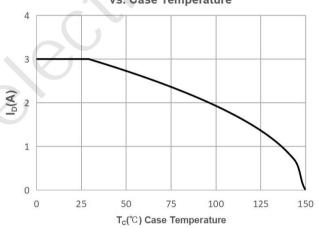
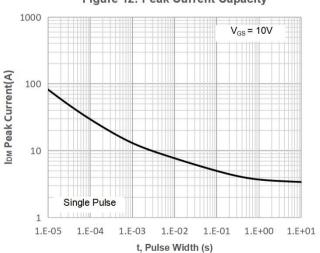


Figure 12: Peak Current Capacity





Test Circuit

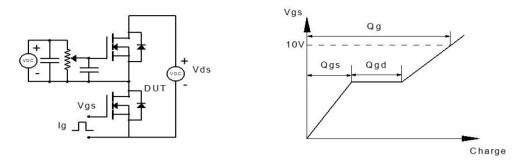


Figure 1: Gate Charge Test Circuit & Waveform

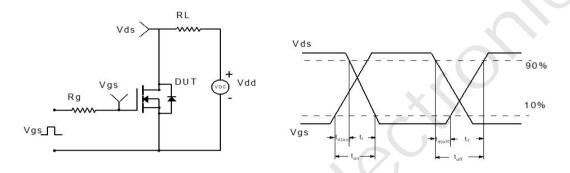


Figure 2: Resistive Switching Test Circuit & Waveform

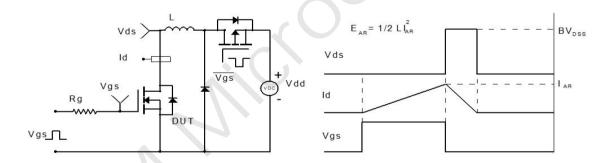


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

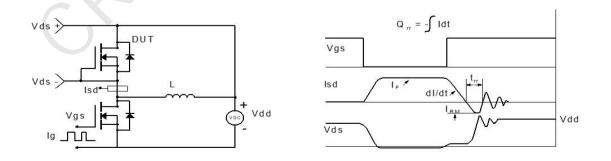
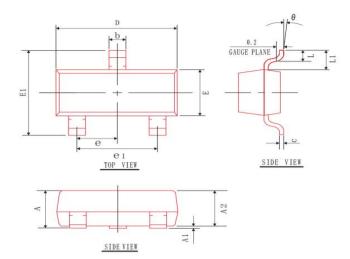


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(SOT-23)



(UNITS OF MEASURE=mm) SYMBOL MIN NOM MAX 0.90 1.05 1.20 A1 0.00 0.05 0.10 0.90 1.00 1.10 0.30 0.40 0.50 0.08 0.10 0.15 D 2.80 2.90 3.00 E 1.20 1.30 1.40 E 1 2.30 2.40 2.50 0.40 L 0.30 0.50 θ 0° 50 10° 0.55 REF L1 e 0.95 BSC

1. 90 REF

COMMON DIMENSIONS

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